Power MOSFET

40 V, 38 A, Single N-Channel, DPAK

Features

- Low R_{DS(on)}
- High Current Capability
- Low Gate Charge
- These are Pb–Free Devices

Applications

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

MANINUM RATINGS (1) = 25 C utiless of the wise stated)					
Parameter			Value	Unit	
Drain-to-Source Voltage			40	V	
e		V _{GS}	±20	V	
Steady	$T_{C} = 25^{\circ}C$	Ι _D	38	А	
State	$T_{C} = 100^{\circ}C$		27		
Steady State	$T_{C} = 25^{\circ}C$	PD	75	W	
Steady	$T_A = 25^{\circ}C$	Ι _D	7.6	А	
State	T _A = 100°C		5.3		
Steady State	T _A = 25°C	P _D	2.9	W	
t _p = 10 μs		I _{DM}	75	А	
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to 175	°C	
Source Current (Body Diode)		۱ _S	36	Α	
Single Pulse Drain-to Source Avalanche Energy – (V _{DD} = 50 V, V _{GS} = 10 V, I _{PK} = 17 A, L = 1 mH, R _G = 25 Ω)		EAS	150	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	
	e Steady State Storage T Storage T Storage T Storage T	heter e T _C = 25°C T _C = 100°C Steady State T _C = 25°C T _C = 25°C T _A = 25°C T _A = 25°C T _A = 100°C Steady State T _A = 25°C T _A = 25°C T _A = 25°C Steady State T _A = 25°C T _A = 25°C T _A = 100°C Steady State t _p = 10 µs Storage Temperature Diode) ource Avalanche t _{GS} = 10 V, I _{PK} = 17 A, oldering Purposes	neterSymboleVDSSeVGSSteadyTC = 25°CIDSteadyTC = 25°CPDSteadyTA = 25°CPDSteadyStateIDMStorage TemperatureTJ, TSTGource Avalanche GS = 10 V, IPK = 17 A,EASoldering PurposesTL	SymbolValueVolumeValueeVDSS40eVDSS40eVGS ± 20 Steady StateT_C = 25°CID T_C = 25°C38 27Steady StateT_C = 25°CPD T_A = 25°C75Steady StateT_A = 25°C T_A = 100°CID 5.37.6 5.3Steady StateT_A = 25°C T_A = 100°CPD 2.92.9topT_A = 25°C 5.3PD 1DM75Steady StateT_A = 25°C T_A = 100°CPD 1DM2.9topT_A = 25°C 5.3PD 1DM2.9Steady StateT_A = 25°C 1.0PD 1.02.9topIDM 1.575Storage TemperatureT_J, T_STG-55 to 1.75Diode)Is 2.636ource Avalanche /GS = 10 V, IPK = 17 A,EAS CAS150oldering PurposesTL 2.60	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.0	°C/W
Junction-to-Case (Note 1)	$R_{\theta JA}$	52	°C/W

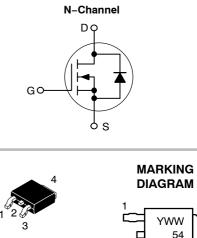
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX (Note 1)
40 V	21 mΩ @ 10 V	38 A



DPAK CASE 369C STYLE 2

Y	= Year
WW	= Work Week
5407N	= Specific Device Code
G	= Pb-Free Device

07NG

ORDERING INFORMATION

Device	Package	Shipping†
NTD5407NG	DPAK (Pb-Free)	75 Units / Rail
NTD5407NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

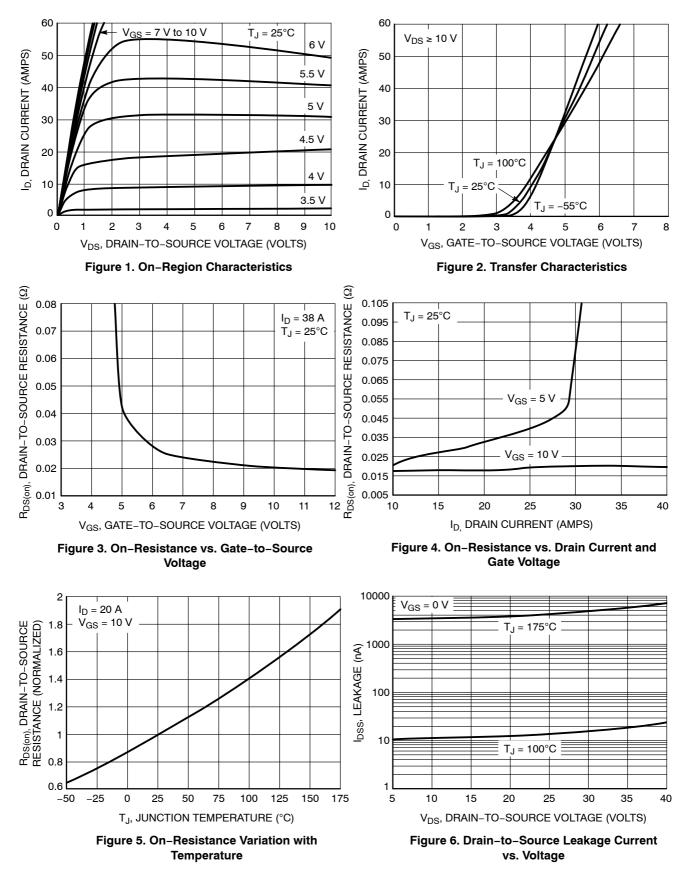
MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise stated)

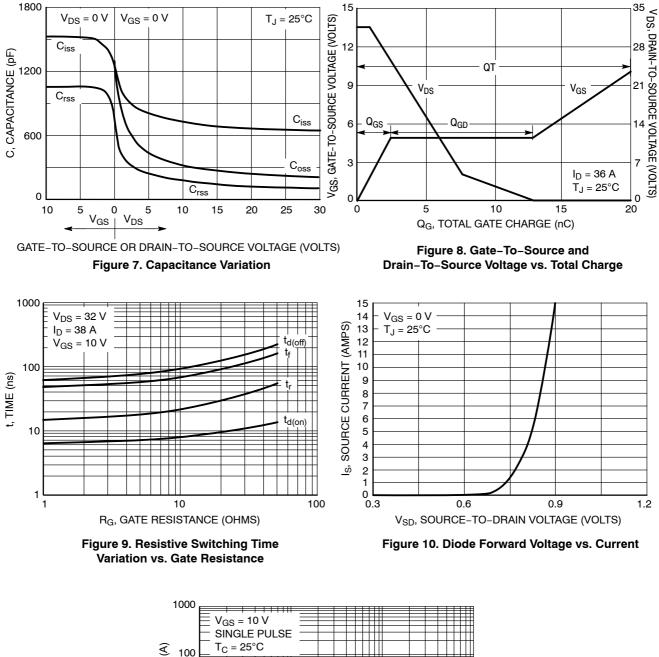
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				39		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 40 V$	T _J = 100°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V ₀	_{3S} = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{I}$	_D = 250 μA	1.5		3.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-6.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 20 A		21	26	mΩ
		V _{GS} = 5.0 V,	I _D = 10 A		32	40	1
Forward Transconductance	9FS	V _{GS} = 10 V,	I _D = 18 A		15		S
CHARGES AND CAPACITANCES			·		-	-	
Input Capacitance	C _{ISS}				615	1000	pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = V _{DS} = 1	∷1.0 MHz, 32 V		173		
Reverse Transfer Capacitance	C _{RSS}	V _{DS} = 32 V			80		
Total Gate Charge	Q _{G(TOT)}				20		nC
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V},$ $I_D = 38 \text{ A}$			2.25		-
Gate-to-Drain Charge	Q _{GD}				10.5		
SWITCHING CHARACTERISTICS, V	GS = 10 V (Note :	3)					
Turn-On Delay Time	t _{d(ON)}				6.8		ns
Rise Time	t _r	V _{GS} = 10 V, V	חם = 32 V,		17		
Turn-Off Delay Time	t _{d(OFF)}	I _D = 38 A, R	_G = 2.5 Ω		66		
Fall Time	t _f		F		51		
SWITCHING CHARACTERISTICS, V	GS = 5 V (Note 3))					
Turn-On Delay Time	t _{d(ON)}				10		ns
Rise Time	t _r	V _{GS} = 5 V, V _I	ם = 20 V,		175		
Turn-Off Delay Time	t _{d(OFF)}	I _D = 20 A, R	_G = 2.5 Ω		13		1
Fall Time	t _f		F		23		1
DRAIN-SOURCE DIODE CHARACTE	ERISTICS (Note	2)					-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.9	1.1	V
		$I_{\rm S} = 5.0 \rm{A}$	T _J = 125°C		0.75		
Reverse Recovery Time	t _{RR}		•		38		ns
Charge Time	t _a	V _{GS} = 0 V, dI _S /d	t = 100 A/us.		20.5		1
Discharge Time	t _b	$I_{\rm S} = 1$			17		1
Reverse Recovery Charge	Q _{RR}				40		nC

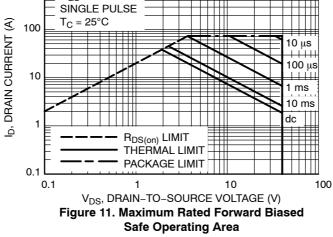
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

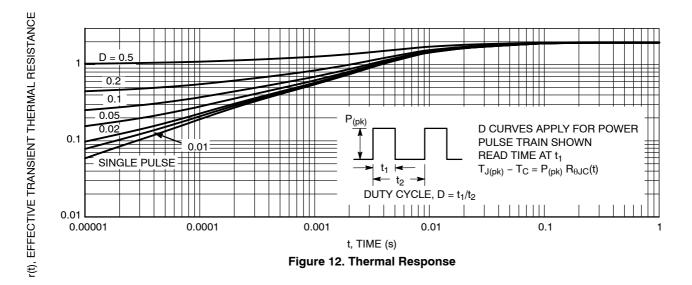


TYPICAL PERFORMANCE CURVES



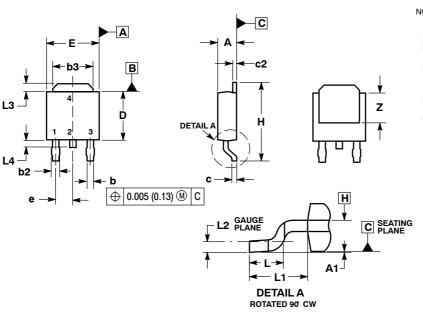


TYPICAL PERFORMANCE CURVES



PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE) CASE 369C-01 ISSUE D

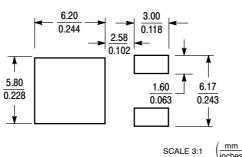


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN
- DIMENSIONS b3, L3 and Z. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD ELASH DROTEUSIONS OR PURPS, MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
e	0.090 BSC		2.29 BSC		
н	0.370	0.410	9.40	10.41	
Г	0.055	0.070	1.40	1.78	
L1	0.108 REF 2.74 REF				
L2	0.020 BSC		0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*



3. SOURCE 4. DRAIN

2 DRAIN

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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